Se	arch Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/806,036	ZHANG ET AL.	
Examiner	Art Unit	
Michael Bernshteyn_	1713	

	SEAR	CHED	
Class	Subclass	Date	Examiner
516	99	6/28/2006	МВ
560	205	6/28/2006	МВ
560	312	6/28/2006	мв
526	328	6/28/2006	МВ

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
560	205	6/28/2006	MB
524	328	6/28/2006	MB

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
EAST (USPAT, JPO, EPO,DERWENT,PREGRANT) Updated Search	6/28/2006	мв
PALM, eDAN INventors and Asiignee Updated Search	6/28/2006	МВ
NPL	6/28/2006	МВ